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Flat shadow mask for color cathode ray tube.

A planar tension mask is disclosed for use in a color cathode ray tube having a substantially flat faceplate. The shadow mask according to the invention has an aperture pattern characterized by the vertical pitch of the apertures being constant, but with the horizontal pitch of the apertures increasing outwardly from the mask center according to a function which is parabolic with horizontal displacement, and parabolic with vertical displacement. The horizontal pitch increase is isotropic in the sense that the increase in pitch is the sum of the horizontal displacement increase and the vertical displacement increase. A color cathode ray tube front assembly having such a shadow mask is also disclosed.

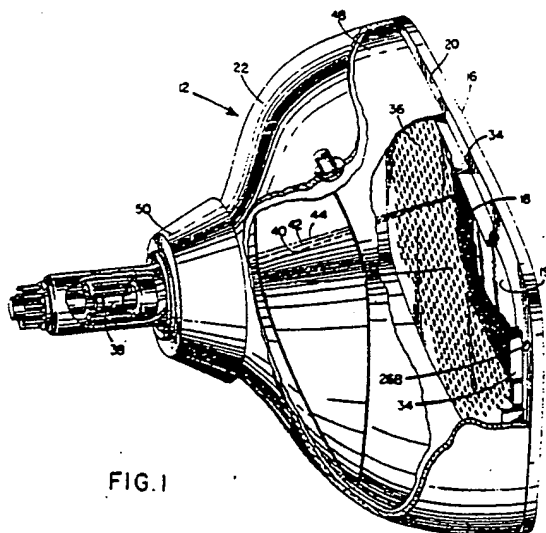


FIG. 1

This invention concerns tension mask color cathode ray tubes, and more particularly, relates to an improved front assembly having a mask with an aperture pattern which reduces beamlet degrouching errors.

One effect of beam misregistration is degrouching of the beamlets, resulting in color impurities. Beam degrouching errors can result from such factors as errors in the geometries of the substantially flat faceplate and the associated planar mask, the in-line condition of the three beams, and the influence of the self-converging yoke.

Dynamic convergence of the three beams of an in-line electron gun is provided in present-day television systems primarily by a self-converging yoke. This type of yoke is typically a hybrid having toroidal-type vertical deflection coils and saddle-type horizontal deflection coils. The yoke contains windings which produce an astigmatic field component that has the effect of maintaining the beams in convergence as they are swept across the screen. The convergence achieved is not without cost, however, as the beam spots are subject to degrouching and distortion in the peripheral areas of the screen. The degrouching effect is compensated for in conventional curved-screen tubes by adjusting the contour of the glass panel; however, when the screen and mask are flat, this is not an option. Any attempt to further modify the configuration of the self-converging yoke field to adapt it to a flat screen is apt to increase degrouching outside the limits of acceptability.

U. S. Patent No. 3,590,303 to Coleclough discloses a shadow mask embodiment in which the center-to-center spacing of the apertures in both the radial and azimuthal directions is greater at the periphery of the mask than at the center thereof, and the center-to-center spacing of the associated phosphor dots in both the radial and tangential directions is likewise greater at the periphery of the screen than at the center. Also, there is disclosed an embodiment in which the phosphor dots increase in size from the center of the screen and are substantially tangential to one another throughout the screen.

U. S. Patent No. 3,686,525 to Naruse et al discloses a shadow mask having apertures aligned along barrel-shaped lines extending in a horizontal direction, and along pin-cushioned lines extending in a vertical direction. The apertures are sized such that the distribution of the electron-beam transmission factor of the mask is graded concentrically about the center of the mask.

U. S. Patent 3,370,591 to Satoh discloses a circular-aperture shadow mask for a color picture tube having an in-line gun in which the horizontal arrangement of the apertures is such as to make the distance between adjacent beam landing areas substantially equal. This equality is accomplished by tilting the angle of the apertures to correspond to the angle (with respect to the x-axis) of the associated electron beams.

U. S. Patent 3,652,895 to Tsuneta et al discloses a shadow mask having rectangular electron-beam-passing apertures (a "slot mask") graduated both vertically and horizontally in size and pitch from the center of the mask to its periphery. The purpose is said to be the improvement in the coefficient of beam transmissivity for the peripheral portion of the mask so as to prevent color shading and to enhance picture brightness. The mask is considered to be a "graded" mask in that the slots are narrower and longer at the mask periphery than at its center.

U. S. Patent 3,947,718 to van Lent discloses a display screen of a color CRT comprising a line pattern of elongated phosphor regions. The apertures in the shadow mask, also elongated, have the shape of an approximately spherical sector, and are arranged along curved lines. During manufacture, apertures are aligned in one flat plane, with the central axis of a linear light source located in the deflection region. The invention is said to provide linear luminescent regions with substantially straight edges, instead of "undulating" edges.

U. S. Patent 2,947,899 to Kaplan discloses a compensated aperture mask structure having a plurality of apertures which are round at the axial aperture, but distorted into an elliptical configuration by radial foreshortening as a function of the distance of the apertures from the axial aperture. The stated purpose is to rectify degrouching errors.

U. S. Patent 2,755,402 to Morrell has a shadow mask containing a multiplicity of "dot-like" aperture elements arranged in a pattern which is systematically related to a pattern of dot-like elements on an adjacent screen. The dot-like elements comprising one of the patterns are of substantially uniform diameter, and the dot-like elements comprising the other pattern diminish in diameter outwardly from a region of maximum diameter near its center.

See also U.S. Patent 3,435,268 to Rublack et al.

These prior disclosures are directed primarily to CRT front assemblies in which the faceplate is curved, and the associated shadow mask is correlatively curved. The disclosures and their solutions are deemed to be inapplicable to compensating for degrouching errors which can occur in a color cathode ray tube having an in-line electron gun and a self-converging yoke, and a front assembly comprising a substantially flat faceplate and an associated planar shadow mask in spaced adjacency thereto.

In describing the invention, certain terminology will be employed and the following is a list of these terms with their respective definitions:

"Screen" - The field of discrete phosphor deposits on the inner surface of the tube faceplate which emit red, green or blue light upon excitation by the electron beam.

5 "Shadow Mask" - A component of a color cathode ray tube located in spaced adjacency to the faceplate, one having a plurality of apertures for the passage of the electron beams that excite phosphors disposed on the screen of the face plate. The shadow mask "shadows" the triads of phosphor deposits on the faceplate so that only the proper beam falls upon the assigned ones of the phosphor deposits. The shadow mask is also referred to as a "color selection electrode", or "parallax barrier". The shadow mask
10 that is the subject of this invention is a flat, or "planar" mask.

"Pitch" - The center-to-center distance between shadow mask apertures. The symbol "Ph" refers to the horizontal pitch, or distance, between aperture centers, and the symbol "Pv" refers to the vertical pitch between aperture centers. Pho and Pvo are, respectively, the horizontal and vertical pitch of the mask apertures at the mask center.

15 "Grade" or "Graded Pitch" or "Graded Aperture Dimension" - A shadow mask in which the pitch and/or aperture dimensions vary from one area of the mask to another; e.g. from the center of the mask to its periphery.

"Electron Beamlet" - The portion of an electron beam passing through a mask aperture.

"Degrouping" - A non-symmetrical placement of the beamlets of a deflected beamlet trio as the trio
20 intercepts the screen. Degrouping error refers to the magnitude of the degroup-induced misregistration of the beamlets relative to the impinged phosphor deposits. As a result of degrouping, a part or all of an outer beamlet or beamlets may fail to land on the assigned phosphor deposit(s) with consequent color impurities and reduced brightness in peripheral areas of the screen.

"Beam Landing Area" - The area of the screen upon which a beamlet falls.

25 "Positive Guard Band" - A condition wherein the beam landing area is smaller than the phosphor element upon which it lands; as a result, the area of the phosphor element unexcited by the beam serves as a positive guard band. The term "negative guard band" means a condition in which the beam landing area is larger than the phosphor element upon which it lands by a predetermined guard band area. In negative guard band screens, the margin of safety, or guard band, that prevents color impurities is
30 conventionally covered with a light-absorbing material.

One aim of the invention is to provide a flat tension mask color cathode ray tube having improved resolution, image brightness, and color purity, and more particularly, to provide, in such a tube, a front assembly with an improved shadow mask aperture pattern which reduces degrouping errors occurring as a result of the combining of a flat mask, substantially flat faceplate, an in-line electron gun, and a self-
35 converging yoke.

The present invention therefore provides a flat shadow mask for use in a color cathode ray tube having a substantially flat faceplate, characterized in that the aperture pattern of said mask has the horizontal pitch of the apertures increasing outwardly from the mask center.

Further features and advantages of the invention will become more apparent from the following
40 description of a preferred embodiment of the invention with reference to the accompanying drawings in which"

Figure 1 is a perspective view of the partly cut away envelope of a color cathode ray tube having a front assembly with a planar shadow mask according to the invention

45 Figure 2 is a plan view of the inner surface of the faceplate of figure 1 showing the relationship of the faceplate to the planar shadow mask; the inset shows a group of enlarged mask apertures located at the mask center;

Figure 3 is an enlarged cut-away view in perspective that shows in greater detail the relationship of the planar shadow mask according to the invention with other tube components;

50 NOTE: The location of the phosphor deposits on the faceplate, and the positioning of the beamlets landing on each of the deposits, is a function of the pitch of the mask. Consequently, to depict mask aperture pitch according to the invention, it is necessary to depict the effect on the phosphor deposits on the faceplate, as is shown in figures 4, 4A, 5 and 8 that follow.

Figure 4 is a view in perspective depicting a section of a shadow mask shown in relation to a section of a faceplate having a group of phosphors deposited thereon activated by beamlets in an ideal relationship;

55 Figure 4A is a plan view of the group of phosphors shown by figure 4;

Figure 5 is a diagrammatic view of the effect of the degrouping of beamlets at a position away from the center of the mask that is in consequence of a combination including a self-converging yoke and an in-line electron gun, and a front assembly comprising a substantially flat faceplate and an associated planar shadow mask in spaced adjacency thereto;

5 Figure 6 is a depiction of horizontal aperture pitch of a shadow mask as a function of screen width based on the formula

$$10 \quad P2 - P1/3 = \left(a \left(\frac{2x}{W} \right)^2 + b \left(\frac{2y}{H} \right)^2 \right) PhO;$$

figure 6A is a depiction of vertical aperture pitch as a function of screen width;

15 Figure 7 is a depiction of horizontal aperture pitch as a function of screen height based on the formula cited for figure 6, above; figure 7A is a depiction of vertical aperture pitch as a function of screen height.

Note: The curves of figures 6 and 6A, and 7 and 7A represent the upper right quadrant of the mask according to the invention; the other quadrants (-x and -y) are substantially mirror images;

20 Figure 8 is a diagrammatic view of the effect of the desired distribution of beamlets on the associated phosphor deposits according to the invention.

Figure 9 is a diagrammatic view of the upper right quadrant of a planar shadow mask having a distribution of apertures according to the invention.

With reference to figures 1 to 3, there is shown a color cathode ray tube 12 having a front assembly with an improved shadow mask support structure according to the invention.

25 The front assembly includes a glass faceplate 16 noted as being flat, or alternately, "substantially flat", in that it may have finite horizontal and vertical radii, for example. Faceplate 16, depicted as being flangeless, is indicated as having on its inner surface 19 a centrally disposed phosphor screen 18 on which is deposited an electrically conductive film (not indicated), typically composed of aluminum. The phosphor screen 18 and the conductive film comprise the electron beam target area.

30 Screen 18 is shown as being surrounded by a peripheral sealing area 20 adapted to be mated with a funnel 22 by means of a suitable cement such as a layer of frit 32. Sealing area 20 has indexing means 24 shown generally as a V-groove 26A in figure 3 opposite a cavity 30A provided in a funnel-sealing area 23 of funnel 22.

35 Ball means 28A conjugate with the indexing elements 26A and 30A complete the indexing means 24 for registering faceplate 16 and funnel 22. As described more fully in our copending application No. 87102413.9, the indexing means 24 usually comprises 3 pairs of mating indexing elements like V-groove 26A, cavity 30A and cooperating ball means 28A which are preferably located at 120 degree intervals in the funnel sealing area.

40 Front assembly 15 includes a tension foil shadow mask support structure 23 secured to the inner surface 19 of faceplate 16 between the centrally disposed screen 18 and the peripheral sealing area 20 of faceplate 16, and enclosing screen 18. The shadow mask support structure 34 is preferably composed of sheet metal, and is secured to the inner surface 19 on opposed sides of screen 18, as indicated by figure 2. A foil shadow mask 36 is secured in tension on structure 34 and has a number of mask apertures 37. The inset in figure 2 shows these apertures 37 greatly enlarged. Normally, the apertures diameter may be 45 around 0.0035 inch, for example.

The cathode ray tube 12 has a neck extending from funnel 22 enclosing an electron gun 38 which is portrayed as emitting three electron beams 40, 42 and 44. The three beams serve to selectively excite to luminescence the phosphor deposits on the screen 18 after passing through the parallax barrier formed by shadow mask 36.

50 An internal magnetic shield 48 provides shielding for the electron beam excursion area and the front assembly 15 from the influence of stray magnetic fields. A self-converging yoke 50 is shown as encircling tube 12 in the region of the junction between funnel 22 and the tube neck. Yoke 50 provides a measure of self-convergence of beams 40, 42 and 44 in the electromagnetic scanning thereof across the screen 18.

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The variation of aperture pattern of the horizontal direction according to the invention can best be understood by reference first to the ideal grouping of beam landings in relation to associated phosphor deposits at the center 17 of the faceplate, where x and y are both equal to 0. This ideal grouping is depicted by figures 4 and 4A--the beam landing areas are indicated as being perfect with relation to the associated phosphor deposits; that is, perfect in concentricity.

NOTE: For purposes of illustration only, the pattern shown by figures 4, 4A, 5 and 8 represents a positive guard band relationship between the phosphor deposits and the beam landing areas. This relationship is indicated in figures 4 and 4A by beam landing area 60, wherein the underlying phosphor deposit 61 is shown diagrammatically as emitting green light under the impact of the electrons. The area 63 between the boundaries of the beam landing area 60 and the phosphor deposit 61 comprises the guard band, noted as being a positive guard band for purposes of illustration. It will also be noted that the other beam landing areas depicted are also concentric with the associated phosphor deposits, indicated diagrammatically as being red-light-emitting and blue-light-emitting. The invention has been, and is preferably practiced, in a negative guard band execution (due to the increased brightness and contrast which results). It is herein illustrated in a positive guard band execution because of the considerably greater ease in depicting (and understanding) the invention in its positive guard band execution.

Such a positive guard band execution is shown by figure 4 wherein a section of faceplate 16 is shown as having on its inner surface; that is, the surface facing the shadow mask 36, a row of phosphor deposits 56. Phosphor deposits 61, 62 and 64 are indicated graphically as emitting green, blue and red light, respectively, under the impact of three electron beamlets 66. The beamlets 66 are depicted as having passed through an aperture 68 in tenses foil shadow mask 36. (The origin of the beamlets; that is, the electron beams 40, 42 and 44 emitted by the electron gun 38 depicted in figure 1, is not depicted in this figure 4.) The beamlets 66 will be noted as being in line in accord with the beam emission of the in-line electron gun 38.

Other phosphor deposits in the same row 56 which are a part of adjacent trios of phosphor deposits, comprise green-light-emitting deposit 72, blue-light-emitting deposit 74, and a red-light-emitting deposit next in sequent (not shown) which are activated by beamlets passing through adjacent aperture 76. The horizontal pitch P_{ho} of mask 36, and the vertical pitch P_{vo} of mask 36, are noted by the respective arrows.

Another row 76 of phosphor deposits is shown as being located beneath row 56. Only two of the deposits are shown: phosphor deposit 78, depicted as emitting red light, and deposit 80, depicted as emitting green light. The third member of the trio--a blue-light-emitting deposit--is not shown. The phosphors of the trio are activated by beamlets (not shown) emerging from aperture 82.

Figure 4A is a plan view of the two rows 56 and 76 of the phosphor deposits on faceplate 16 shown by figure 4. P_1 is the horizontal pitch of the phosphor deposits of common color emission, indicated by way of example as being green-light-emitting phosphor deposits 61 and 72. Pitch $P_1/3$ is indicated as being the spacing between the centers of adjacent phosphor deposits 61, 62, 64 and 72. P_4 is indicated as representing the pitch of the rows of phosphor deposits in a vertical direction. The beam landings, indicated diagrammatically in figures 4 and 4A by the shaded areas, will be noted as being concentric with the respective phosphor deposit; this is a condition achieved only at the center of the screen. However, with a mask having a uniform hexagonal array of apertures with constant horizontal aperture pitch, the perfect beam landings achieved at the screen center are not achieved away from the center.

The horizontal degrouping error grows parabolically with the horizontal and vertical screen position. The effect of the resultant degrouping away from the screen center in a horizontal direction is indicated by figure 5 for a mask not having a grouping of apertures according to the invention. Beam landing area 86 of blue-light-emitting phosphor deposit 88, energized by a "blue" beamlet, is depicted in close adjacency to beam landing area 89 of red-light-emitting phosphor deposit 90, energized by a "red" beamlet. The respective guard bands 92 and 94 will be seen as being overcome to the point where color impurities and color shading can occur. As indicated by figure 5, the horizontal degrouping error (" P_{he} ") can be expressed as $P_2 - P_1/3$.

The foregoing observations can be expressed by formula

$$P_2 - P_1/3 = a \frac{2x}{W}^2 + b \frac{2y}{H}^2 \quad P_{ho}; \text{ where "a"}$$

and "b" are constants. This relationship relates directly to the astigmatic aberration characteristics of the yoke design. Constants "a" and "b" are functions of the tube size, screen aspect ratio, beam deflections angles, and the characteristics of the gun and yoke, which are an in-line gun and self-converging yoke.

In figure 6, the horizontal mask pitch along the horizontal axis of the mask array (i.e., $y = 0$) is depicted by curve 98 as a function of the horizontal position (i.e., x). In figure 7, the horizontal mask pitch along the vertical axis of the mask array (i.e., $x = 0$) is depicted by curve 100 as a function of the vertical position (i.e., y). Figure 6 represents the growth of the error for the constant "a", and figure 7 the growth of constant "b".

Figures 6 and 7 depict respectively the parabolic growth of the horizontal degroupping error with vertical and horizontal screen position. In figure 7, the y axis represents the horizontal pitch at the degrouped beam landing areas as a function of the distance from the center of the screen, where Pho is the horizontal pitch of the beam landing areas (and phosphor deposits) in the screen center. Where the constant "b" is 0.06, for example, the horizontal pitch of the beam landing areas at the top of the screen is $1 + 0.06$, or 1.06 times the horizontal pitch Pho at the screen center. In figure 6, the constant "a" may be 0.08, by way of example. As a result, the horizontal pitch of the degrouped beam landing areas as a function distance from faceplate is $1 + 0.08$, or 1.08 times Pho . (These relationships are further defined in conjunction with figure 9.) The labels on the x axis: viz., $W/4$, represent demarcations of the axis based on the dimensions of the mask; e.g., if the mask is 12 inches in width, $W/4$ would represent 3 inches (taking into account the fact that there is $-W/4$ as well as $+W/4$).

It is notable according to the invention that the vertical degroupping error is theoretically zero for all screen positions. The fact is shown diagrammatically by figures 6A and 7A wherein the growth of the vertical pitch of the beam landing areas is depicted as a function of distance from the screen center in both the horizontal direction (figure 6A) and the vertical direction (figure 7A). The growth is depicted by the respective plots 102 and 104 as being nonexistent, or zero, according to the invention.

With reference now to figure 8, it will be noted that the horizontal pitch, $P6$, of the mask apertures away from the mask center is changed according to the invention from a constant pitch $P1$ at mask center (see figure 4A) in such a way that the horizontal degroupping error at any point on the screen away from the mask center equals zero at all screen positions. In other words, the horizontal spacing between adjacent phosphor deposits is equal to one-third of $P6$ at this or any other mask position away from the center. It is also important to understand that the vertical pitch, $P4$, of the mask apertures according to the invention remains constant throughout the mask. The mask apertures according to the invention are characterized by having a variable horizontal pitch and a uniform, or constant, vertical pitch.

The characteristics of a variable horizontal pitch and a constant vertical pitch are illustrated in figure 9, which represents the upper right quadrant of shadow mask 36 according to the invention. The horizontal pitch of the apertures increases outwardly according to the invention from mask center 106 according to a function which is parabolic with horizontal displacement. The pitch Pho adjacent to the mask center 106 is depicted as increasing to 1.06 Pho at 108—the 12 o'clock edge position of the mask. At 110—the three o'clock edge position on the mask—the distance between aperture centers is 1.08 Pho , and at 112—the top right corner of the mask—the distance between aperture centers is 1.14 Pho . Further according to the invention, the horizontal pitch of the apertures is isotropic in the sense that the increase in pitch is the sum of the horizontal displacement contribution and the vertical displacement contribution. In other words, the top right corner 112 has a horizontal pitch increase equal to the sum of the 3 o'clock increase plus the 12 o'clock increase.

Moving away from the mask center 106 along a horizontal line, the mask apertures become increasingly separated horizontally, but are constant in vertical separation according to the invention. Similarly, moving away from the mask center 106 along a vertical line, the mask apertures again become increasingly separated horizontally, but are constant in vertical spacing. In both cases, the rate of increase is parabolic, but the parabolic functions are somewhat different, as described above. Moving away from mask center 106 along a diagonal line, the increasing horizontal spacing of the mask apertures represents a sum of each of the aforesaid components.

Also with reference to figure 9, it will be observed that by having the horizontal pitch (but not the vertical pitch) of the apertures increasing outwardly from mask center 106, the apertures define a locus of points identified by curved line 114 that indicates a pincushion distortion in the horizontal direction, but no significant distortion in the vertical direction. In effect, the variable horizontal pitch increases outwardly from the mask center 106 according to the relation

$$1 + a \frac{2x}{W}^2 + b \frac{2y}{H}^2 \text{ } Pho,$$

where, as noted, the coefficients a and b are determined by such factors as the tube size, screen aspect

ratio, beam deflection angles, and the characteristics of the gun and yoke, noted as being the in-line gun and the self-converging yoke; H and W are the height and width of the mask array; x and y are the horizontal and vertical locations at a point on the mask array; and Pho is the pitch of the mask in the horizontal direction at the screen center. The coefficients a and b are both in the range of from 0.02 to 0.30 according to a preferred form of the invention.

Claims

1. A flat shadow mask for use in a color cathode ray tube having a substantially flat faceplate, characterized in that the aperture pattern of said mask has the horizontal pitch of the apertures increasing outwardly from the mask center.

2. A shadow mask according to claim 1, characterized in that the vertical pitch of the apertures is substantially constant throughout the mask.

3. A shadow mask according to claim 1 or 2, characterized in that the horizontal pitch of the apertures increase outwardly from the mask center such that said apertures define loci of points having a pincushion distortion in the horizontal direction, but no significant distortion in the vertical direction.

4. A shadow mask according to claim 1, 2 or 3, characterized in that the horizontal pitch of the apertures increase outwardly from the mask center according to a function which is parabolic with horizontal position and parabolic with vertical position.

4. A shadow mask according to and of claims 1 to 4, characterized in that the horizontal pitch of the apertures is variable according to the relation

$$\left(1 + a \left(\frac{2x}{W} \right)^2 + b \left(\frac{2y}{H} \right)^2 \right) \text{Pho},$$

wherein the coefficients a and b are determined by such factors as tube size, screen aspect ratio, beam deflection angles, and the characteristics of the in-line gun and self-converging yoke; H and W are the height and width of the mask array; x and y are the horizontal and vertical locations at a point on the mask array; and Pho is the horizontal pitch of the apertures at the mask center.

6. A shadow mask according to claim 5, characterized in that the coefficients a and b are both in the range of 0.02 to 0.30.

7. A front assembly for use in a color cathode ray tube having a self-converging yoke and an in-line electron gun and comprising a substantially flat faceplate and an associated planar shadow mask in spaced adjacency thereto, characterized in that said shadow mask has an aperture pattern wherein the horizontal pitch of the apertures increases outwardly from the mask center.

8. A front assembly according to claim 7, characterized in that the shadow mask has an aperture pattern wherein the vertical pitch of the apertures is substantially constant throughout the mask.

9. A front assembly according to claim 7 or 8, characterized in that the aperture pattern of said shadow mask has the horizontal pitch of the apertures increasing outwardly from the mask center such that said apertures define loci of points having a pincushion distortion in the horizontal direction, but no significant distortion in the vertical direction.

10. A front assembly according to claim 7, 8 or 9, characterized in that the aperture pattern of said shadow mask has a horizontal pitch which increases outwardly from the mask center according to a function which is parabolic with horizontal position and parabolic with vertical position.

11. A front assembly according to any of claims 7 to 10, characterized in that said shadow mask has a variable horizontal pitch which increases outwardly from the mask center according to the relation

$$\left(1 + a \left(\frac{2x}{W} \right)^2 + b \left(\frac{2y}{H} \right)^2 \right) \text{Pho},$$

wherein the coefficients a and b are determined by such factors as the tube size, screen aspect ratio, beam deflection angles, and the characteristics of the in-line gun and self-converging yoke; H and W are the height and width of the mask array; x and y are the horizontal and vertical locations at a point on the mask array; and Pho is the horizontal pitch of the apertures at the mask center.

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12. A front assembly according to claim 11, characterized in that the coefficients a and b are both in the range of 0.02 to 0.30.

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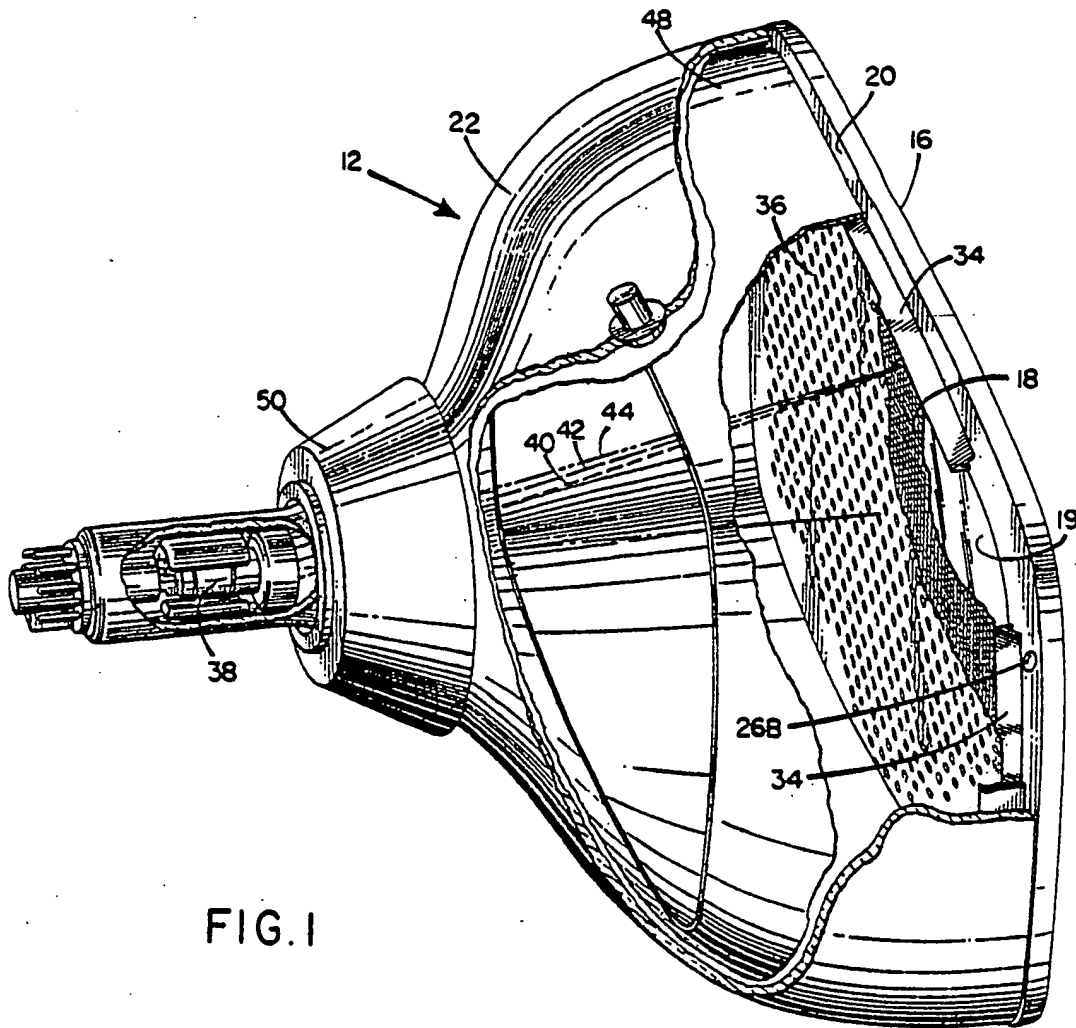


FIG. 1

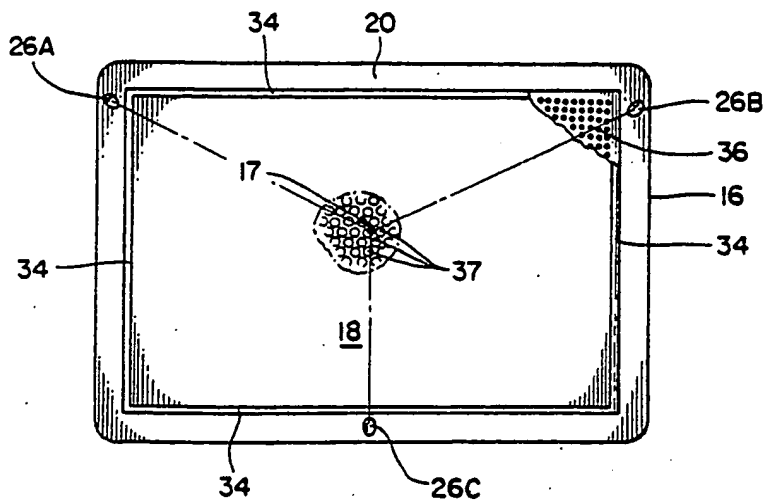
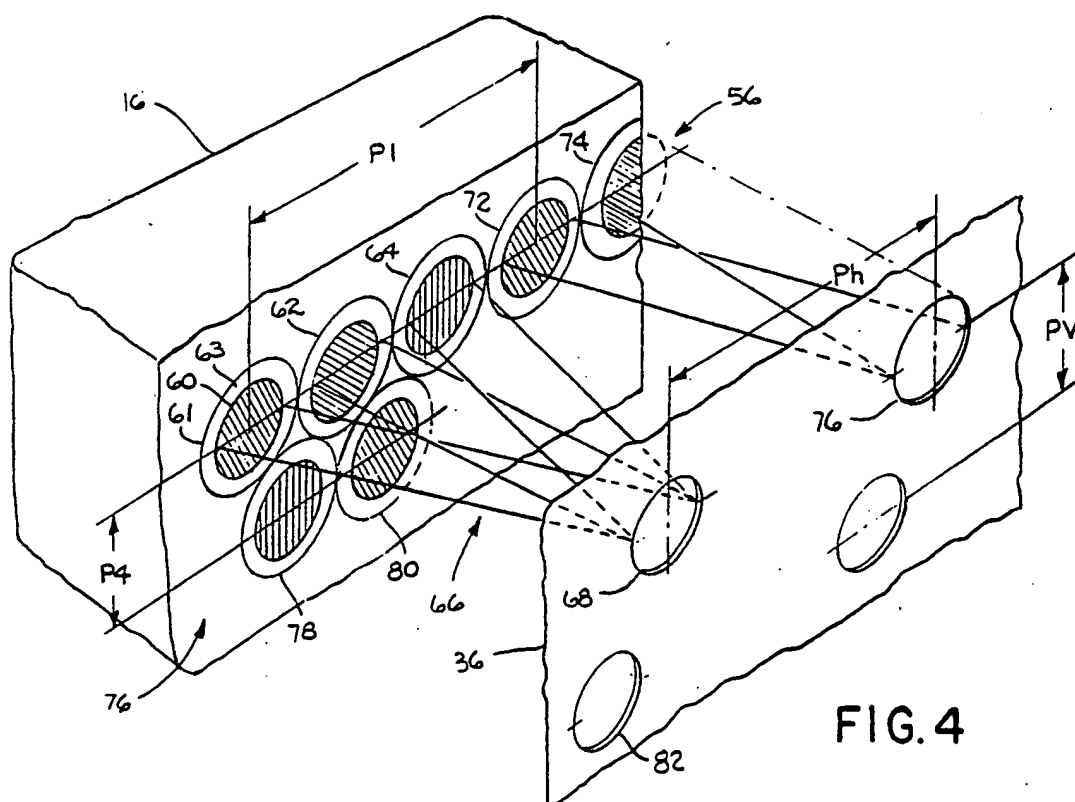
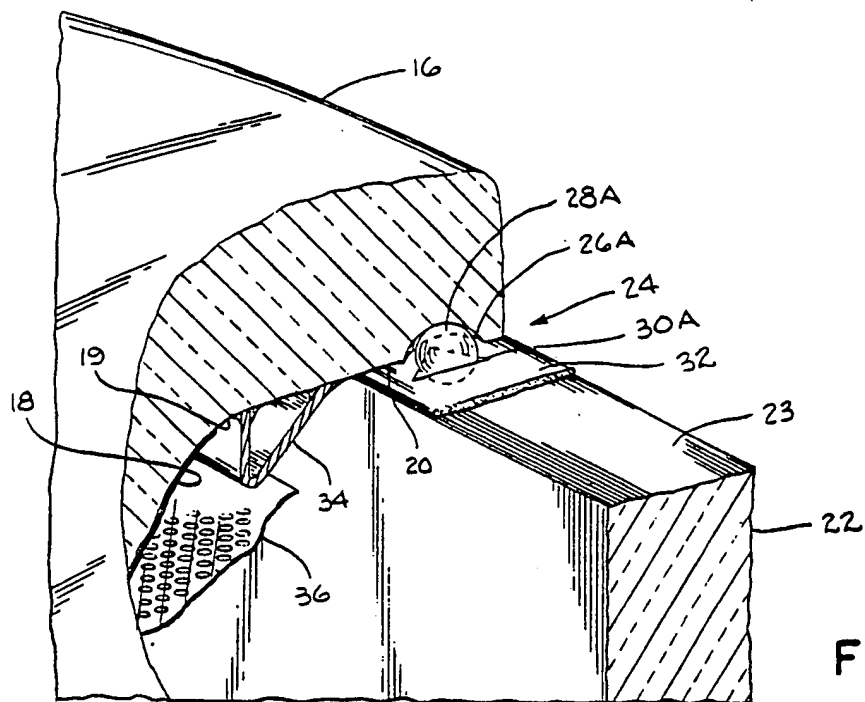


FIG. 2



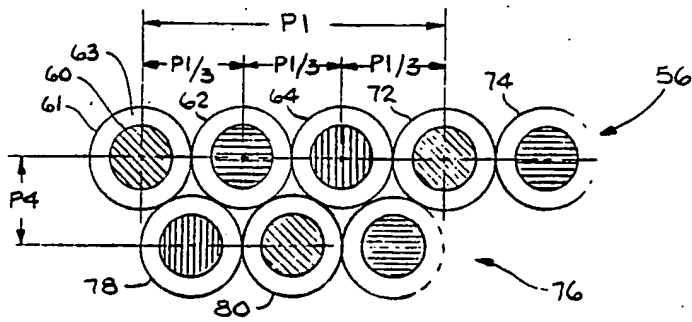


FIG. 4A

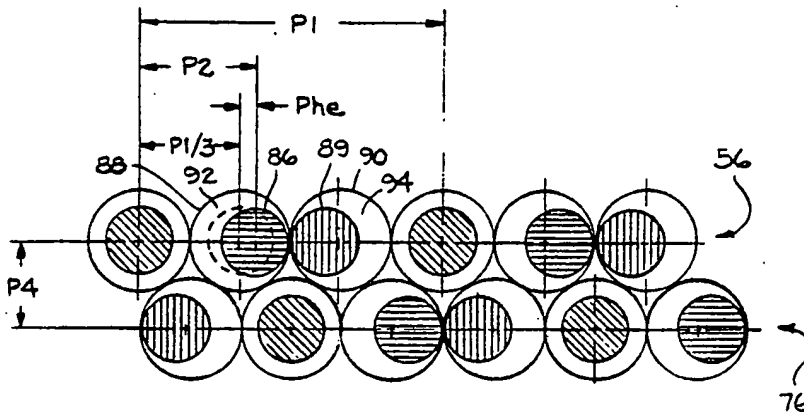


FIG. 5

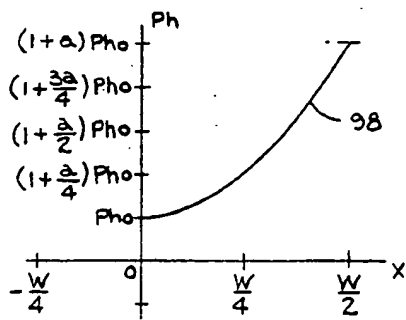


FIG. 6

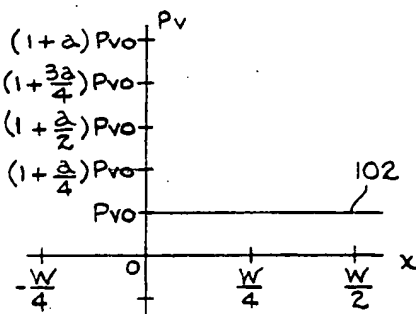


FIG. 6A

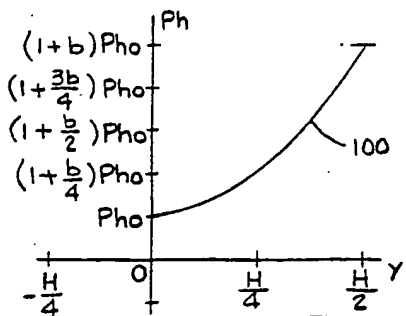


FIG. 7

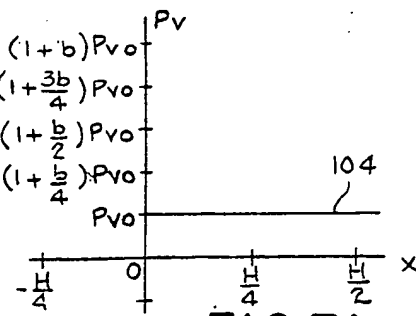


FIG. 7A

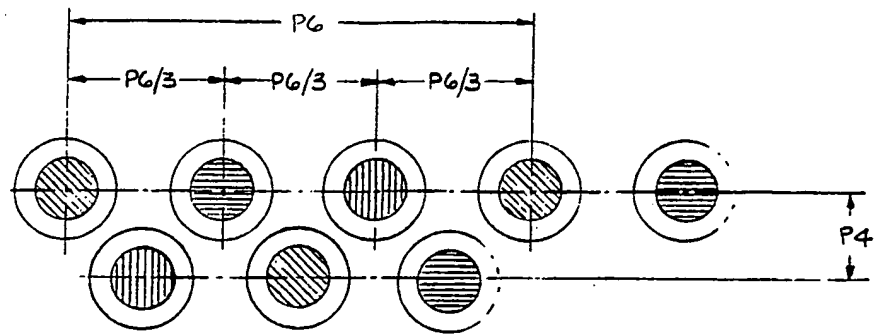


FIG. 8

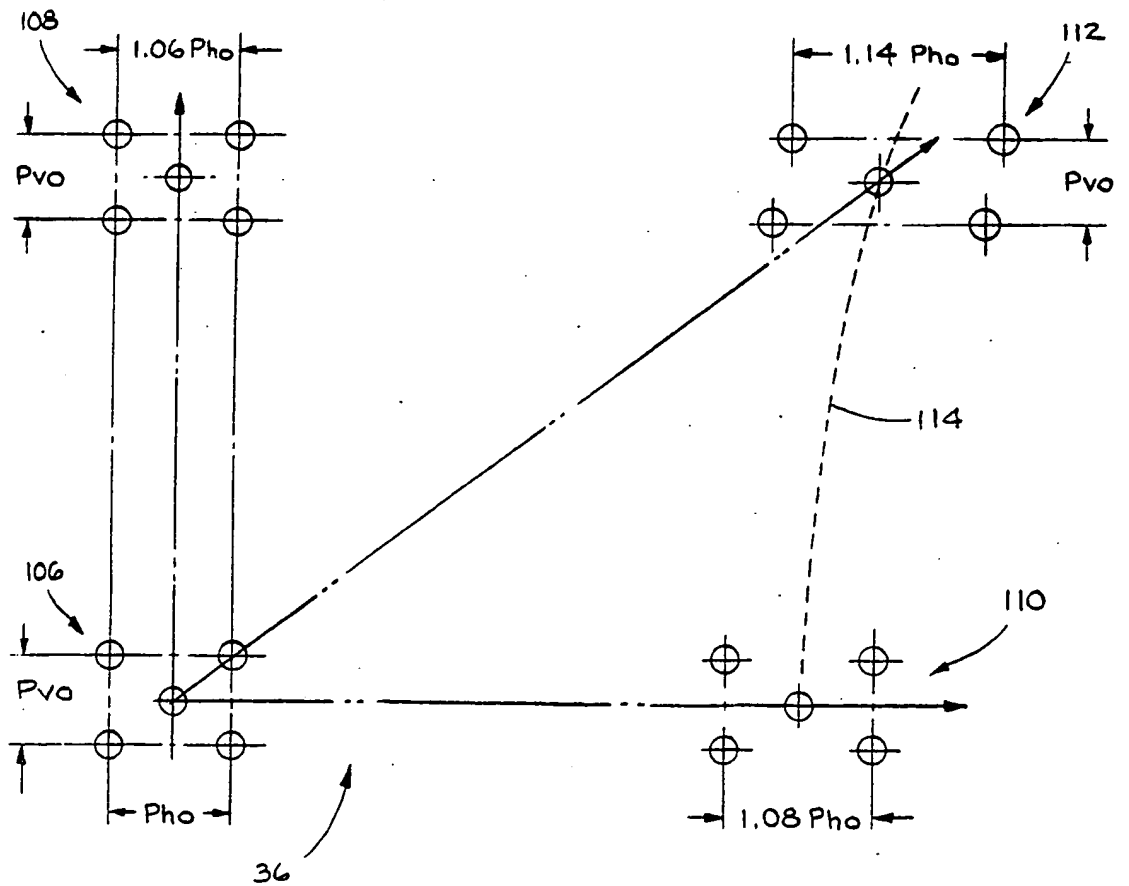


FIG. 9



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(54) Flat shadow mask for color cathode ray tube.

(57) A planar tension mask is disclosed for use in a color cathode ray tube having a substantially flat faceplate. The shadow mask according to the invention has an aperture pattern characterized by the vertical pitch of the apertures being constant, but with the horizontal pitch of the apertures increasing outwardly from the mask center according to a function which is parabolic with horizontal displacement, and parabolic with vertical displacement. The horizontal pitch increase is isotropic in the sense that the increase in pitch is the sum of the horizontal displacement increase and the vertical displacement increase. A color cathode ray tube front assembly having such a shadow mask is also disclosed.

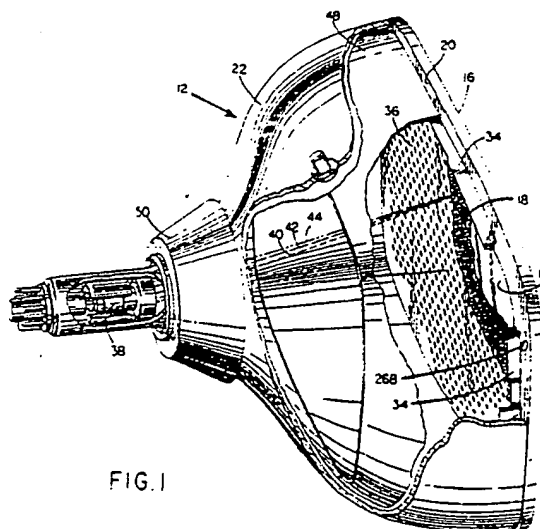


FIG. 1

EP 0 239 083 A3



EP 87 10 4353

DOCUMENTS CONSIDERED TO BE RELEVANT

Category	Citation of document with indication, where appropriate, of relevant passages	Relevant to claim	CLASSIFICATION OF THE APPLICATION (Int. Cl. ⁴)
A	EP-A-0 121 628 (TEKTRONIX) * Abstract; figures 1-5; page 5, line 28 - page 6, line 2 *	1,7	H 01 J 29/07
A	--- JP-A-59 165 338 (TOKYO SHIBAURA) * Abstract; figures 4,7; column 2, lines 12-39 * & PATENT AB- STRACTS OF JAPAN, vol. 9, no. 15 (E-291)[1738], 22nd January 1985, & US-A-4 636 683 -----	1,7	
			TECHNICAL FIELDS SEARCHED (Int. Cl. ⁴)
			H 01 J 29/00 H 01 J 9/00
The present search report has been drawn up for all claims			
Place of search THE HAGUE		Date of completion of the search 10-11-1987	Examiner CENTMAYER
CATEGORY OF CITED DOCUMENTS			
X : particularly relevant if taken alone Y : particularly relevant if combined with another document of the same category A : technological background O : non-written disclosure P : intermediate document T : theory or principle underlying the invention E : earlier patent document, but published on, or after the filing date D : document cited in the application L : document cited for other reasons & : member of the same patent family, corresponding document			

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